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				First Named Inventor	CLARK, Roger L.
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Examiner Initials	Cite No.	U.S. Patent Document Number Code	Kind	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	(Including Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc...), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	T
AK		JACKSON, HAROLD W., Tactical Miniature Crystal Oscillator, Proc. 34 th Annual Frequency Control Symposium, USAERADCOM, May 1980, pp. 449-456, Ft. Monmouth, NJ USA	
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Examiner Signature	<i>And Kufarb</i>	Date Considered	2/21/03
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